## Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/765,540	BHATTACHARYA ET AL.	
Examiner	Art Unit	
lan N. Moore	2616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	463,465, 466, 469-476	7/23/2007	INM
	493-496		
	509,510		
	514,535		
	537-540		
	516,517		
	395.1,399		
	395.6,.61		
	395.64		
709	231,236	7/23/2007	INM
	223-227		
	221		
379	406.01	7/23/2007	INM
	406.03		

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consult with Donald Storm for search in class 704.	7/23/2007	INM
Consult with Harry Hong (XP) for search in class 379.	7/23/2007	INM
Inventor and assignee search (see search history printout)	7/23/2007	INM
Consult with Chau Nguyen (SPE) before rejections claims 1-3,5,6,15,16,18-20 and and allowing claim 7.	5/30/2007	INM
EAST (USPAT, USPGPUB, EPO,USOCR,FERS,JPO,DERWENT,I BM_TDB)- see search history printout	7/23/2007	INM
Consult with Kwang Yao (SPE) and confirm that claim 15 is not a single means claim.	7/23/2007	INM

Search Notes	(continued)
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10/765,540	BHATTACHARYA ET AL.	•
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	SEARCHED		
Class	Subclass	Date	Examiner
379	406.08	7/23/2007	INM
	386		
	88.01	7/24/2007	INM
	88.07		
	to 88.1		
	392.01		
	to 395.01		
704	233	7/23/2007	INM

ERFERENC	E SEARCH	ED
Subclass	Date	Examiner
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	1	Subclass Date

	DATE	EXMR
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